



FORM PTO-1449 INFORMATION DISCLOSURE CITATION	Attorney Docket: 1232-5299	Serial No.: 10/783,218
	Applicant: Kenji Yamazoe et al.	
	Filing Date: February 20, 2004	Group Art Unit: TBA

U.S. PATENT DOCUMENTS

Examiner Initial	Patent Number	Publication Date	Name	Class	Sub-Class	Filing Date

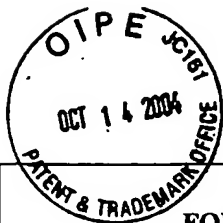
FOREIGN PATENT DOCUMENTS

Examiner Initial	Patent Number	Publication Date	Country	Class	Sub-Class	Translation
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Papers, etc.)

<i>AR</i>	Korean Office Action with English translation	11-24-05	<i>AR</i>

Examiner <i>A. Trasco</i>	Date Considered <i>9/13/06</i>
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Kenji Yamazoe et al.Filing Date:
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1756

U.S. PATENT DOCUMENTS

Examiner Initial	Patent Number	Issue Date	Name	Class	Sub-Class	Filing Date
<i>ASL</i>	2002/0177048	11/28/02	Saitoh et al.			

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OTHER DOCUMENTS (Including Author, Title, Date, etc.)

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A. Dosaseo

Date Considered

9-13-06

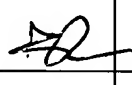

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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**
(Not for submission under 37 CFR 1.99)



Application Number	10783218
Filing Date	2004-02-20
First Named Inventor	YAMAZOE
Art Unit	1756
Examiner Name	TBA
Attorney Docket Number	1232-5299

U.S. PATENTS

Examiner Initial*	Cite No	Patent Number	Kind Code ¹	Issue Date	Name of Patentee or Applicant of cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
	1	6048647		2000-04-11	Miyazaki et al.	
	2	6841801		2005-01-11	Kim et al.	


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U.S. PATENT APPLICATION PUBLICATIONS

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	1	20020151157		2002-10-17	Kim et al.	
	2	20050064304		2005-03-24	Kim et al.	








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	1	6-289591 A	JP		1994-10-18			<input checked="" type="checkbox"/>



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Art Unit	1756	
Examiner Name	TBA	
Attorney Docket Number	1232-5299	

	2	19510564 A	DE		1995-10-26		<input checked="" type="checkbox"/>
	3	07-281413	JP		1995-10-27		<input checked="" type="checkbox"/>
	4	2002080745	KR		2002-10-26		<input checked="" type="checkbox"/>
	5	02/088843	WO		2002-07-11		<input type="checkbox"/>
	6	2002-351052	JP		2002-12-04		<input checked="" type="checkbox"/>
	7	2003-234285	JP		2003-08-22		<input checked="" type="checkbox"/>
	8	2005-142599	JP		2005-06-02		<input checked="" type="checkbox"/>

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NON-PATENT LITERATURE DOCUMENTS


Examiner Initials*	Cite No	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, pages(s), volume-issue number(s), publisher, city and/or country where published.	T5
	1	Hur et al., "Effect of pattern density for contact windows in an attenuated phase shift mask", Proc. SPIE Vol. 2440, 1995, pp. 278-289.	<input type="checkbox"/>
	2	Singapore Patent Office Letter dated February 1, 2006 forwarding Australian Patent Office Search Report AND Written Opinion dated 12/21/2005	<input type="checkbox"/>

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EXAMINER SIGNATURE

Examiner Signature		Date Considered	9-13-06
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